

Notice of References Cited	Application/Control No. 10/562,581	Applicant(s)/Patent Under Reexamination OKAZAKI ET AL.	
	Examiner Derek J. Rosenau	Art Unit 2834	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0107300	06-2003	Nakamura et al.	310/324
*	B	US-6,778,029	08-2004	Mizusawa, Syuichi	331/68
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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